<table>
<thead>
<tr>
<th>Name</th>
<th>Role</th>
</tr>
</thead>
<tbody>
<tr>
<td>Peter Smith</td>
<td>Senior Developer</td>
</tr>
<tr>
<td>Sarah Johnson</td>
<td>Quality Assurance Engineer</td>
</tr>
<tr>
<td>John Doe</td>
<td>Project Manager</td>
</tr>
</tbody>
</table>

**Department:**

Software Development

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**Session 2:** Materials and Processes on Semiconductor/Display Devices

- **Expo 2023**
- **Location:** Chicago
- **Date:** August 15-17

**Sessions:**

- Materials and Processes on Semiconductor/Display Devices
- Technology Trends in Display Devices

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**Environment and Process:**

- Materials and Processes on Semiconductor/Display Devices
- In-process Quality Control

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**Technical Paper:**

Title: "Innovative Techniques in Display Device Manufacture"

Authors: Sarah Johnson, John Doe

Abstract:

This paper presents a new approach to improving the efficiency and quality of display device manufacture. The authors describe a novel in-process quality control method that has been implemented in a leading semiconductor company, resulting in a significant reduction in defect rates.

Keywords:

- Display Devices
- In-process Quality Control
- Manufacturing Efficiency

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**Exhibit:**

A whiteboard with a flowchart indicating the steps involved in the new quality control method.

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